Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/662,426	LEE ET AL.		
Examiner	Art Unit		
Saeed T. Chaudhry	1746		

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SEARCHED					
Class	Subclass	Date	Examiner		
15	21.1, 77, 88.2, 88.3, 88.4 102	11/9/2005	La 7		
451	124, 140	11/9/2005	1		
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INTERFERENCE SEARCHED					
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	DATE	EXMR
Consulted Mark Spisich Robert Rose	11/9/2005	